

450V N-Channel MOSFET

General Features

- Proprietary New Planar Technology
- $R_{DS(ON),typ.}$ =0.48 Ω @ V_{GS} =10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- Ballast and Lighting
- DC-AC Inverter
- Other Applications

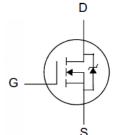
Ordering Information

Part Number	Package	Brand	
PTA09N45	TO-220F	Z	

Lead Free Package and Finish

BV _{DSS}	R _{DS(ON),typ.}	I _D
450V	0.48Ω	9A





TO-220F

Package No to Scale

Absolute Maximum Ratings

T_C=25 °C unless otherwise specified

Symbol	Parameter	PTA09N45	Unit
V _{DSS}	Drain-to-Source Voltage ^[1]	450	V
V_{GSS}	Gate-to-Source Voltage	±30	V
I _D	Continuous Drain Current	9	
I _{D @ Tc =100} ℃	Continuous Drain Current @ Tc=100℃	Figure 3	А
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2]	Figure 6	
E _{AS}	Single Pulse Avalanche Energy	500	mJ
dv/dt	Peak Diode Recovery dv/dt ^[3]	5.0	V/ns
В	Power Dissipation	40	W
P _D	Derating Factor above 25℃	0.32	W/℃
T _L T _{PAK}	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	°C
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTA09N45	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	3.125	20.44
R _{θJA}	Thermal Resistance, Junction-to-Ambient	100	°C/ W



Electrical Characteristics

OFF Characteristics T_J =25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	450			٧	V _{GS} =0V, I _D =250uA
Desire to One and Lead are One and			1	•	V _{DS} =450V, V _{GS} =0V	
I _{DSS}	Drain-to-Source Leakage Current			100	uA)0	V_{DS} =360V, V_{GS} =0V, T_J =125 $^{\circ}$ C
1	Cato to Source Lankage Current			+100	nΛ	V _{GS} =+30V, V _{DS} =0V
I _{GSS}	Gate-to-Source Leakage Current			-100	nA	V _{GS} =-30V, V _{DS} =0V

ON Characteristics

T_J =25°C unless otherwise specified

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Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance ^[4]		0.48	0.65	Ω	V _{GS} =10V, I _D =4.5A
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$, $I_{D}=250uA$
gfs	Forward Transconductance ^[4]		12		S	VDS=20V,ID=9A

Dynamic Characteristics

Essentially independent of operating temperature

Jiiaiiio	Ecocitiany independent of oper			rating temperature		
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		1120			\/ -0\/
C _{rss}	Reverse Transfer Capacitance		11		pF	V_{GS} =0V, V_{DS} =25V, f=1.0MH _Z
C _{oss}	Output Capacitance		92			
Q _g	Total Gate Charge		20			
Q_{gs}	Gate-to-Source Charge		5		nC	V_{DD} =225V, I_{D} =9A, V_{GS} =0 to 10V
Q_{gd}	Gate-to-Drain (Miller) Charge		5			

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		11			
trise	Rise Time		10			V_{DD} =225V, I_{D} =9A,
td(OFF)	Turn-Off Delay Time		18		ns	V_{GS} =10V Rg=4.7 Ω
tfall	Fall Time		10			3



Source-Drain Body Diode Characteristics

T_J=25℃ unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[4]			9	۸	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[4]			36	Α	MOSFET
V _{SD}	Diode Forward Voltage		-	1.5	V	I _S =9A, V _{GS} =0V
trr	Reverse recovery time		300		ns	V_{GS} =0 V ,IF=9 A ,
Qrr	Reverse recovery charge		1.0		uC	dir/dt=100A/μs

Note:

^[1] T_J=+25℃ to +150℃

^[2] Repetitive rating; pulse width limited by maximum junction temperature. [3] ISD= 10A di/dt < 100 A/µs, VDD < BVDSS, TJ=+150 °C.

^[4] Pulse width≤380µs; duty cycle≤2%.



Typical Characteristics

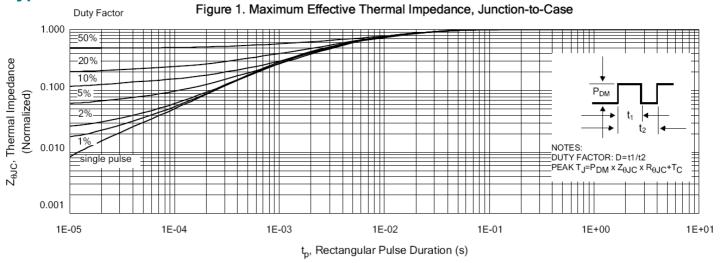


Figure 2. Max. Power Dissipation vs Case Temperature

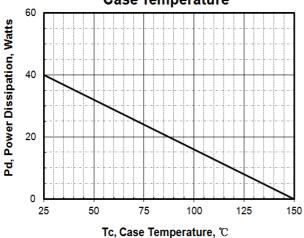


Figure 4. Typical Output Characteristics

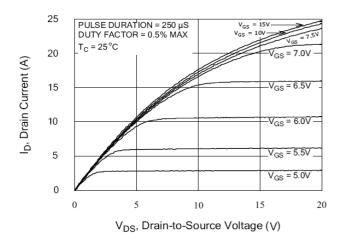


Figure 3 .Maximum Continuous Drain

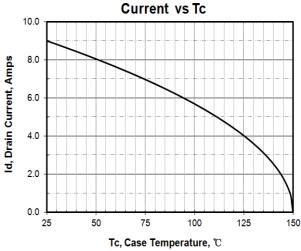
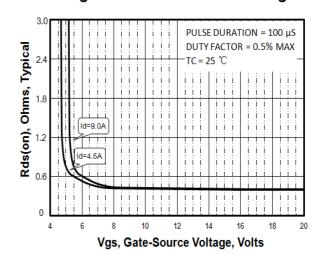


Figure 5. Rdson vs Gate Voltage

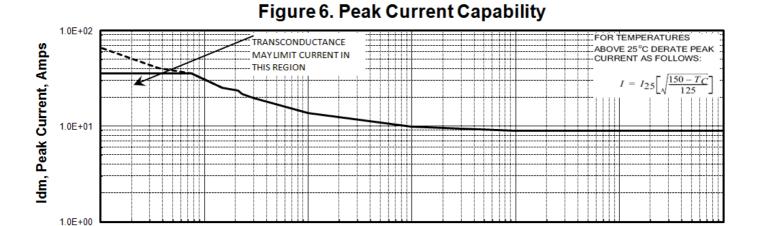


10.0E+0



Typical Characteristics(Cont.)

10.0E-6



t, Pulse Width, Seconds

Figure 7. Typical Transfer Characteristics

100.0E-6

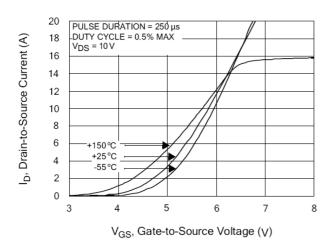


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

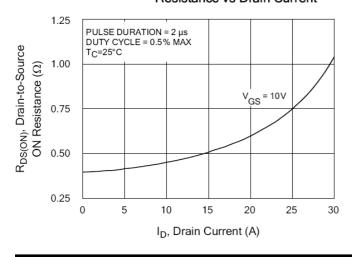


Figure 8. Unclamped Inductive Switching Capability

1.0E+0

100.0E-3

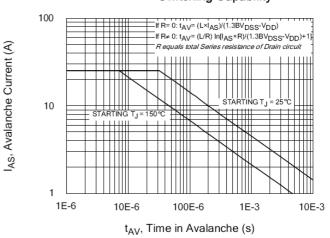
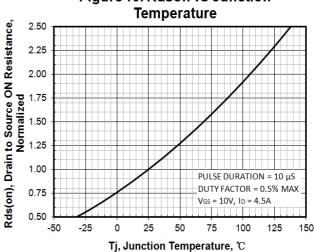


Figure 10. Rdson vs Junction





Typical Characteristics(Cont.)

Figure 11. Typical Breakdown Voltage vs Junction Temperature

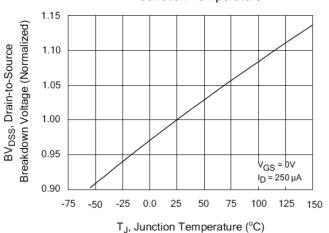
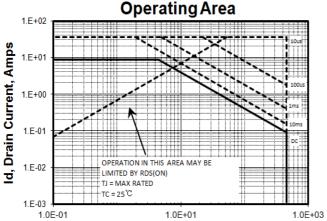


Figure 13 . Maximum Safe
Operating Area



Vds, Drain Source Voltage, Volts

Figure 15. Typical Gate Charge

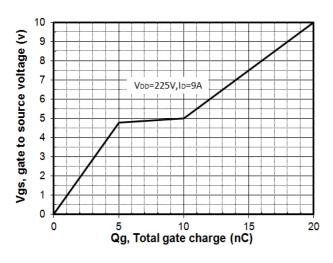


Figure 12. Typical Threshold Voltage vs Junction Temperature

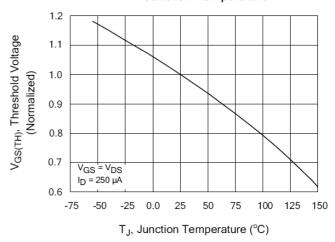


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

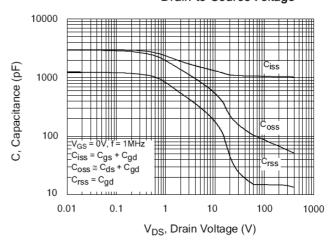
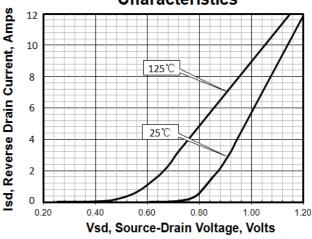


Figure 16.Body Diode Transfer Characteristics





Test Circuits and Waveforms

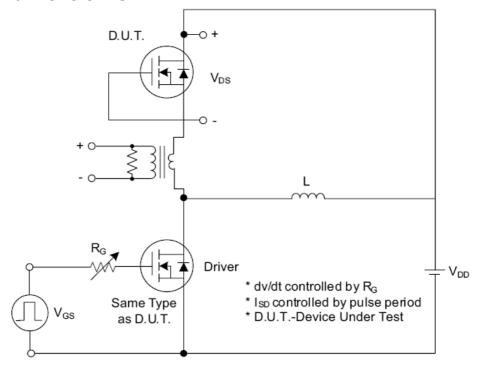


Fig. 1.1 Peak Diode Recovery dv/dt Test Circuit

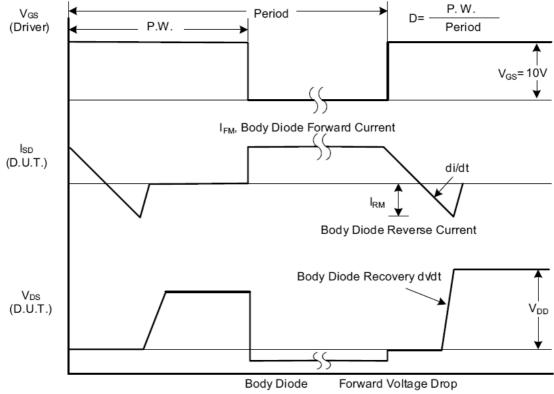


Fig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

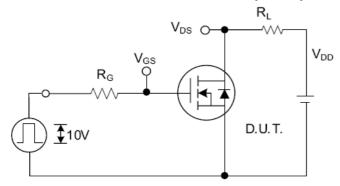


Fig. 2.1 Switching Test Circuit

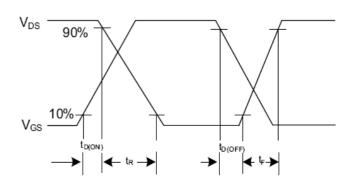


Fig. 2.2 Switching Waveforms

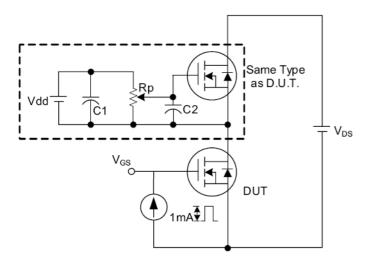


Fig. 3 . 1 Gate Charge Test Circuit

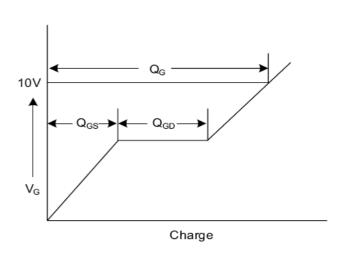


Fig. 3.2 Gate Charge Waveform

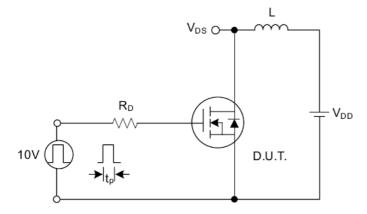


Fig. 4.1 Unclamped Inductive Switching Test Circuit

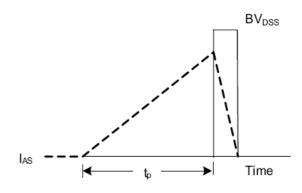


Fig. 4.2 Unclamped Inductive Switching Waveforms



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